Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,195	CHANG ET AL.	
Examiner	Art Unit	
lio M/ L	2611	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	261	10/15/2006	JL
		L	<u></u>

INT	ERFEREN	CE SEARCH	ED
Class	Subclass	Date	Examiner
375	261	10/15/2006	JL
	1		

(INCLUDING SE	CH NOTES ARCH STRATE	GY)
	DATE	EXMR
all east databases	10/15/200	06 JL
inventorship	10/15/200	06 JL